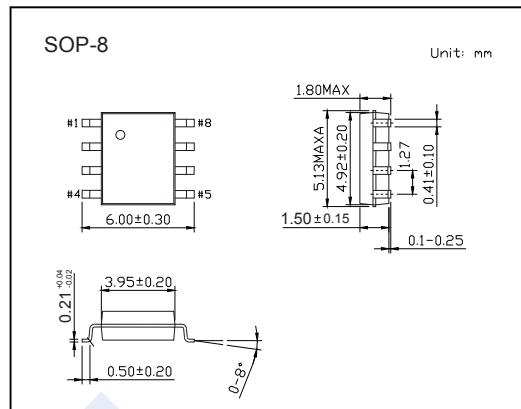


Dual N-Channel MOSFET

KI8810DY

■ Features

- $V_{DS} (V) = 20V$
- $I_D = 7 A$
- $R_{DS(ON)} < 20m\Omega$ ($V_{GS} = 4.5V$)
- $R_{DS(ON)} < 30m\Omega$ ($V_{GS} = 2.5V$)
- $R_{DS(ON)} < 50m\Omega$ ($V_{GS} = 1.8V$)
- ESD Rating: 2KV HBM



■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 8	
Continuous Drain Current	I_D	7	A
		5.7	
Pulsed Drain Current	I_{DM}	25	
Power Dissipation	P_D	1.25	W
		0.8	
Thermal Resistance.Junction- to-Ambient	R_{thJA}	100	$^\circ C/W$
		156	
Thermal Resistance.Junction- to-Lead	R_{thJC}	57.6	
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature Range	T_{stg}	-55 to 150	

Dual N-Channel MOSFET

KI8810DY

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DSS}	$I_D=250 \mu\text{A}, V_{GS}=0\text{V}$	20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$			1	uA
		$V_{DS}=20\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$			5	
Gate-Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$			± 10	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250 \mu\text{A}$	0.4		1.1	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=4.5\text{V}, I_D=7\text{A}$			20	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=5.5\text{A}$			30	
		$V_{GS}=1.8\text{V}, I_D=5\text{A}$			50	
On State Drain Current	$I_{D(on)}$	$V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$	25			A
Forward Transconductance	g_{FS}	$V_{DS}=5\text{V}, I_D=7\text{A}$			12	S
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$			1200	pF
Output Capacitance	C_{oss}				160	
Reverse Transfer Capacitance	C_{rss}				80	
Total Gate Charge	Q_g	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=7\text{A}$			14	nC
Gate Source Charge	Q_{gs}				4.2	
Gate Drain Charge	Q_{gd}				2.6	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, R_L=1.54 \Omega, R_G=3 \Omega$			270	ns
Turn-On Rise Time	t_r				320	
Turn-Off Delay Time	$t_{d(off)}$				3	
Turn-Off Fall Time	t_f				2.2	
Body Diode Reverse Recovery Time	t_{rr}	$I_F=7\text{A}, V_{GS}=-9\text{V}, dI/dt=100\text{A}/\mu\text{s}$			30	nC
Body Diode Reverse Recovery Charge	Q_{rr}				6.5	
Maximum Body-Diode Continuous Current	I_s				2	A
Diode Forward Voltage	V_{SD}	$I_s=1\text{A}, V_{GS}=0\text{V}$			1	V

■ Marking

Marking	8810 KA***
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Dual N-Channel MOSFET

KI8810DY

■ Typical Characteristics

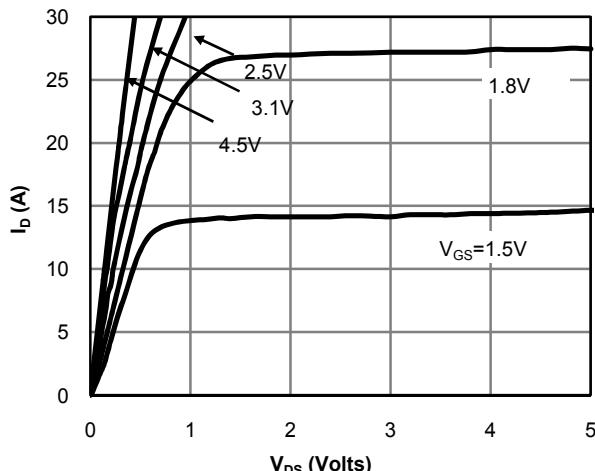


Fig 1: On-Region Characteristics

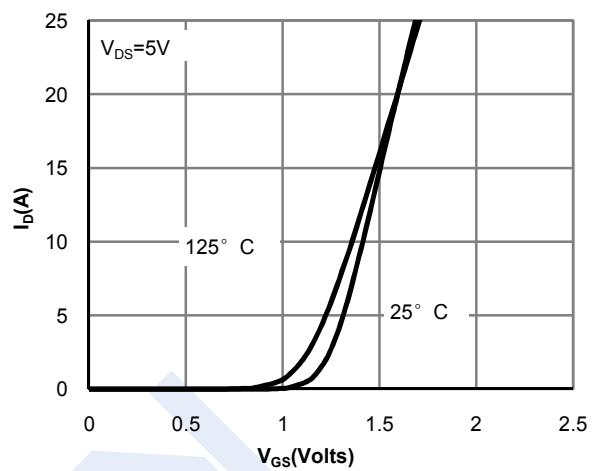


Figure 2: Transfer Characteristics

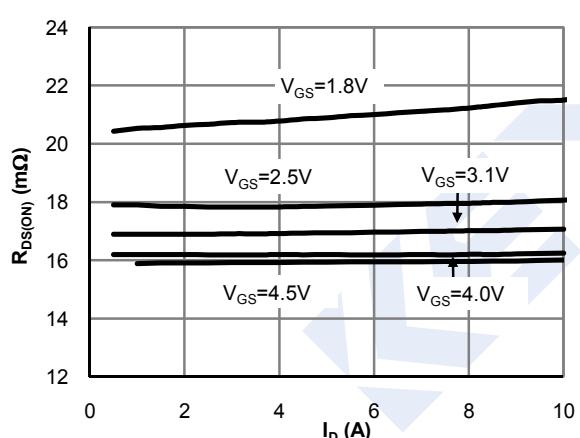


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

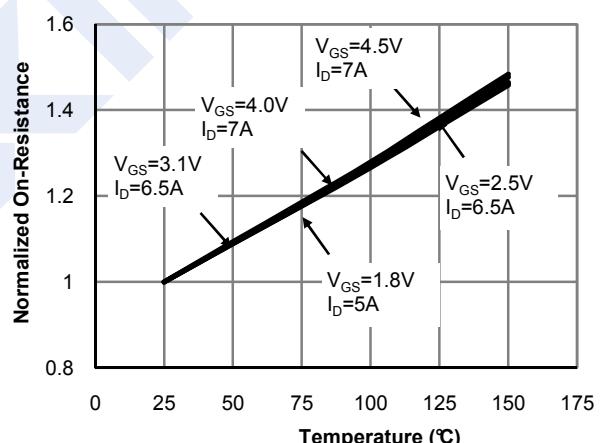


Figure 4: On-Resistance vs. Junction Temperature

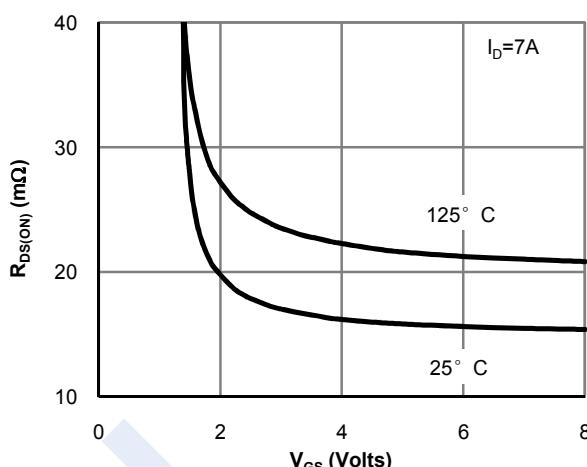


Figure 5: On-Resistance vs. Gate-Source Voltage

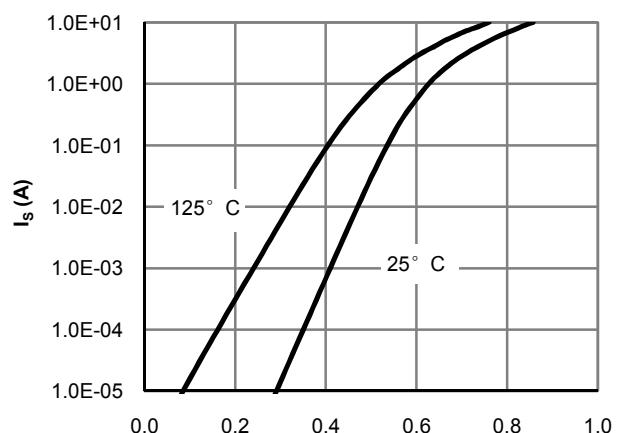


Figure 6: Body-Diode Characteristics

Dual N-Channel MOSFET

KI8810DY

■ Typical Characteristics

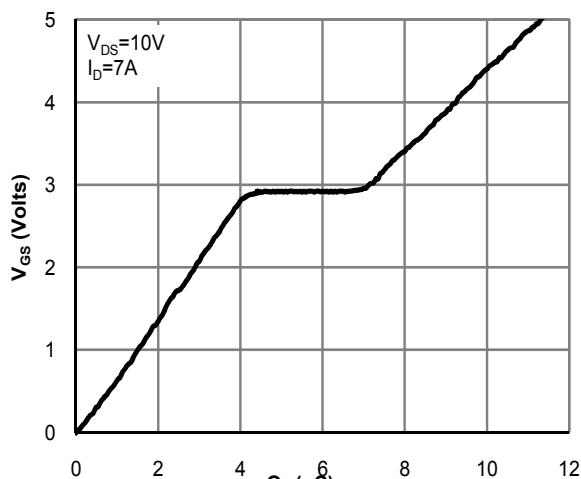


Figure 7: Gate-Charge Characteristics

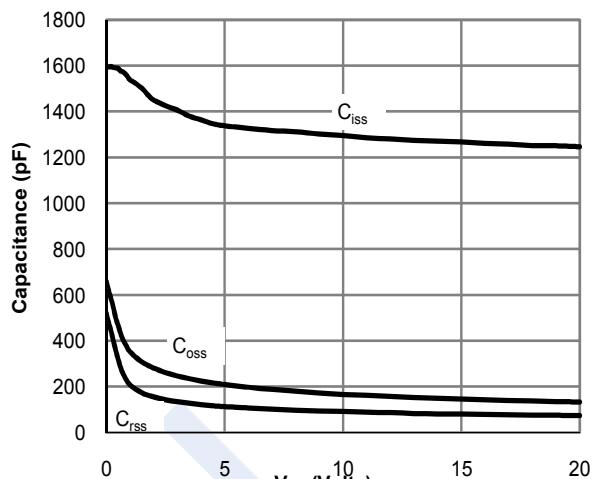


Figure 8: Capacitance Characteristics

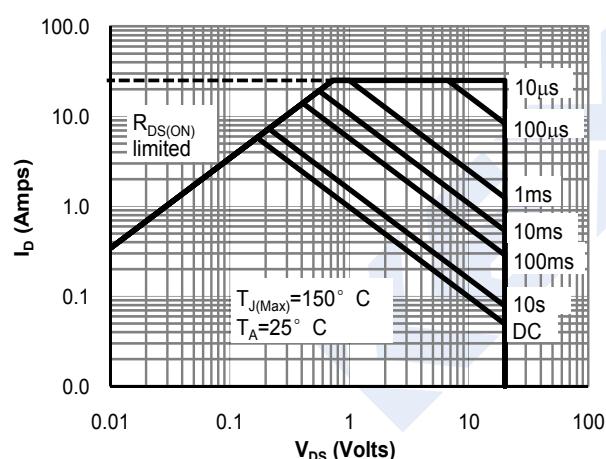


Figure 9: Maximum Forward Biased Safe Operating Area

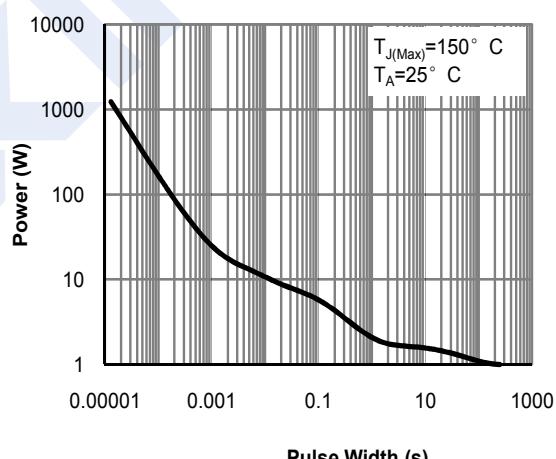


Figure 10: Single Pulse Power Rating Junction-to-Ambient

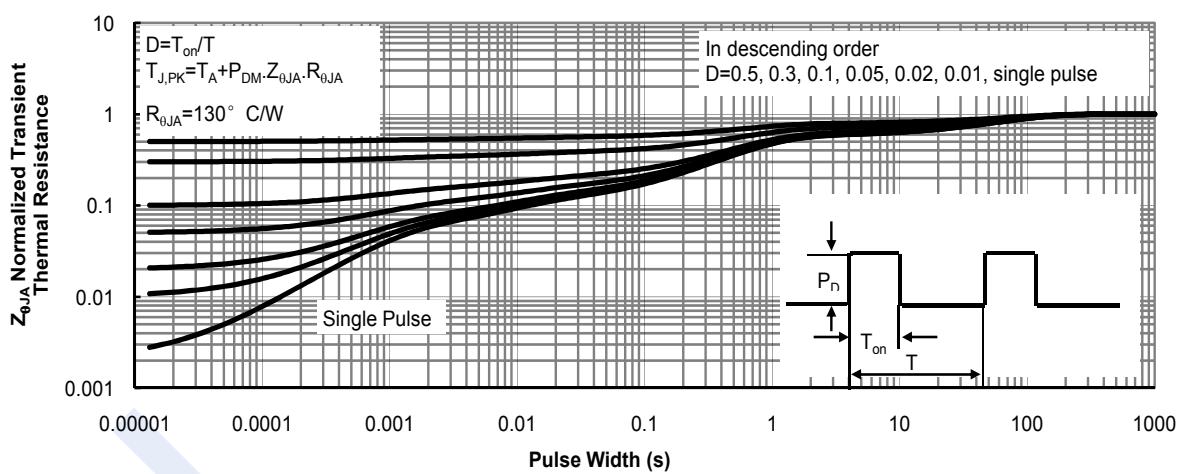


Figure 11: Normalized Maximum Transient Thermal Impedance